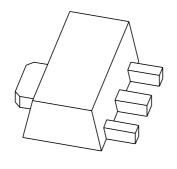
# **DISCRETE SEMICONDUCTORS**

# DATA SHEET



PBSS4480X 80 V, 4 A NPN low V<sub>CEsat</sub> (BISS) transistor

Product specification Supersedes data of 2004 Aug 5

2004 Oct 25





# 80 V, 4 A NPN low V<sub>CEsat</sub> (BISS) transistor

# **PBSS4480X**

### **FEATURES**

- High hFE and low VCEsat at high current operation
- High collector current capability: I<sub>C</sub> maximum 4 A
- High efficiency leading to less heat generation.

### **APPLICATIONS**

- Medium power peripheral drivers; e.g. fan, motor
- Strobe flash units for DSC and mobile phones
- Inverter applications; e.g. TFT displays
- · Power switch for LAN and ADSL systems
- Medium power DC-to-DC conversion
- · Battery chargers.

### **DESCRIPTION**

NPN low V<sub>CEsat</sub> transistor in a SOT89 (SC-62) plastic package.

PNP complement: PBSS5480X.

### **MARKING**

TYPE NUMBER	MARKING CODE <sup>(1)</sup>
PBSS4480X	*1Y

### Note

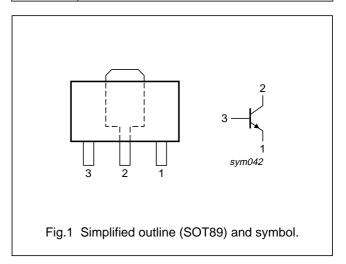
- 1. \* = p: made in Hong Kong.
  - \* = t: made in Malaysia.
  - \* = W: made in China.

### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	80	V
I <sub>C</sub>	collector current (DC)	4	Α
I <sub>CM</sub>	peak collector current	10	Α
R <sub>CEsat</sub>	equivalent	54	mΩ
	on-resistance		

## **PINNING**

PIN	DESCRIPTION	
1	emitter	
2	collector	
3	base	



## **ORDERING INFORMATION**

TYPE NUMBER	PACKAGE				
TIFE NOMBER	NAME DESCRIPTION VERSION				
PBSS4480X	<ul> <li>plastic surface mounted package; collector pad for good heat transfer; 3 leads</li> </ul>		SOT89		

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### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

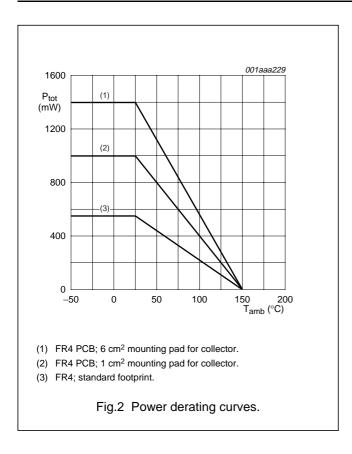
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	80	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	80	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	5	V
I <sub>C</sub>	collector current (DC)	note 4	_	4	Α
I <sub>CRM</sub>	repetitive peak collector current	$t_p \le 10 \text{ ms}; \ \delta \le 0.1$	_	6	Α
I <sub>CM</sub>	peak collector current	$t = 1 \text{ ms or limited by } T_{j(max)}$	_	10	Α
I <sub>B</sub>	base current (DC)		_	1	А
I <sub>BM</sub>	peak base current	t ≤ 300 μs	_	2	А
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C			
		notes 1 and 2	_	2.5	W
		note 2	_	550	mW
		note 3	_	1	W
		note 4	_	1.4	W
		note 5	_	1.6	W
Tj	junction temperature		_	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

### **Notes**

- 1. Operated under pulsed conditions; pulse width  $t_p \le 10$  ms; duty cycle  $\delta \le 0.2$ .
- 2. Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm<sup>2</sup>.
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm<sup>2</sup>.
- 5. Device mounted on a 7 cm² ceramic printed-circuit board, 1 cm² single-sided copper and tin-plated. For other mounting conditions, see *"Thermal considerations for SOT89 in the General Part of associated Handbook"*.

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# 80 V, 4 A NPN low V<sub>CEsat</sub> (BISS) transistor

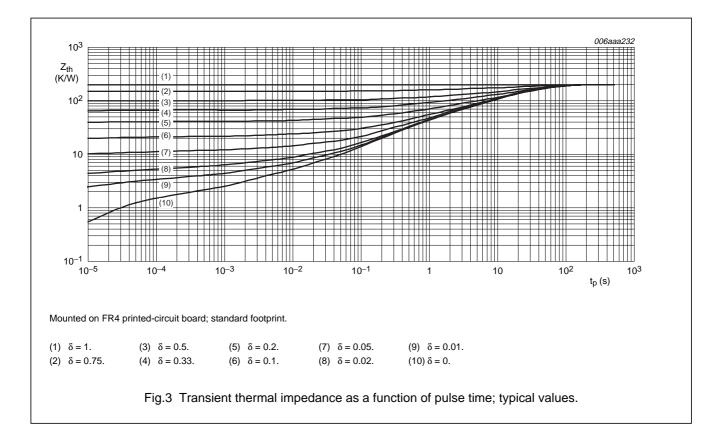
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### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th(j-a)</sub>	thermal resistance from junction	in free air		
	to ambient	notes 1 and 2	50	K/W
		note 2	225	K/W
		note 3	125	K/W
		note 4	90	K/W
		note 5	80	K/W
R <sub>th(j-s)</sub>	thermal resistance from junction to soldering point		16	K/W

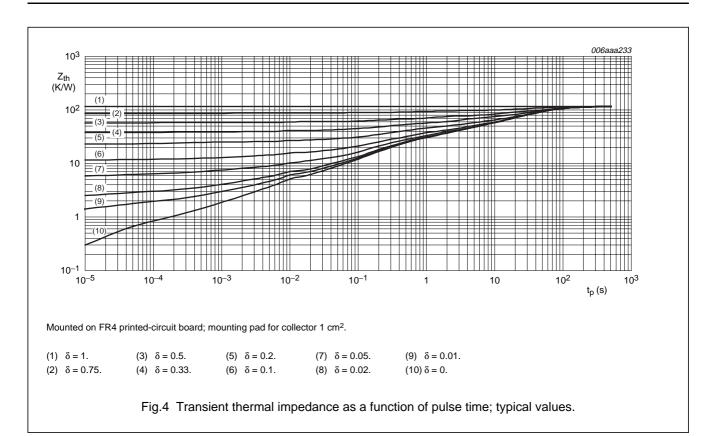
#### **Notes**

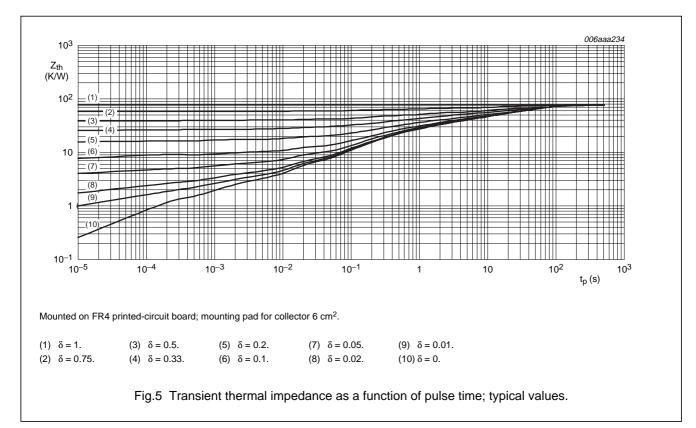
- 1. Operated under pulsed conditions; pulse width  $t_p \le 10$  ms; duty cycle  $\delta \le 0.2$ .
- Device mounted on a printed-circuit board, single-sided copper, tin-plated and standard footprint.
- 3. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 1 cm<sup>2</sup>.
- 4. Device mounted on a printed-circuit board, single-sided copper, tin-plated and mounting pad for collector 6 cm<sup>2</sup>.
- 5. Device mounted on a 7 cm<sup>2</sup> ceramic printed-circuit board, 1 cm<sup>2</sup> single-sided copper and tin-plated. For other mounting conditions, see "Thermal considerations for SOT89 in the General Part of associated Handbook".



# 80 V, 4 A NPN low V<sub>CEsat</sub> (BISS) transistor

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# 80 V, 4 A NPN low $V_{CEsat}$ (BISS) transistor

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## **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

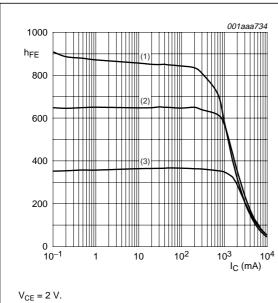
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = 80 \text{ V}; I_{E} = 0 \text{ A}$	_	_	100	nA
		$V_{CB} = 80 \text{ V}; I_{E} = 0 \text{ A};$ $T_{j} = 150 ^{\circ}\text{C}$	_	_	50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	V <sub>CE</sub> = 80 V; V <sub>BE</sub> = 0 V	_	_	100	nA
I <sub>EBO</sub>	emitter-base cut-off current	V <sub>EB</sub> = 5 V; I <sub>C</sub> = 0 A	_	_	100	nA
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 2 V; I <sub>C</sub> = 0.5 A	250	400	_	_
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 1 A; note 1	250	400	_	_
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 2 A; note 1	175	270	_	_
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 4 A; note 1	80	140	_	_
V <sub>CEsat</sub>	collector-emitter saturation	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	_	25	40	mV
	voltage	$I_C = 1 \text{ A}; I_B = 50 \text{ mA}$	_	55	80	mV
		$I_C = 2 \text{ A}; I_B = 40 \text{ mA}$	_	110	160	mV
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 200 mA; note 1	_	170	230	mV
		I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; note 1	_	200	270	mV
R <sub>CEsat</sub>	equivalent on-resistance	I <sub>C</sub> = 5 A; I <sub>B</sub> = 500 mA; note 1	_	40	54	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	_	0.78	0.85	V
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 50 mA	_	0.79	0.9	V
		I <sub>C</sub> = 1 A; I <sub>B</sub> = 100 mA; note 1	_	0.82	0.95	V
		I <sub>C</sub> = 4 A; I <sub>B</sub> = 400 mA; note 1	_	0.95	1.05	V
V <sub>BEon</sub>	base-emitter turn-on voltage	I <sub>C</sub> = 2 A; V <sub>CE</sub> = 2 V	_	0.78	0.85	V
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 10 V; f = 100 MHz	120	150	-	MHz
C <sub>c</sub>	collector capacitance	$I_E = i_e = 0 \text{ A}; V_{CB} = 10 \text{ V};$ f = 1 MHz	_	35	50	pF

## Note

1. Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

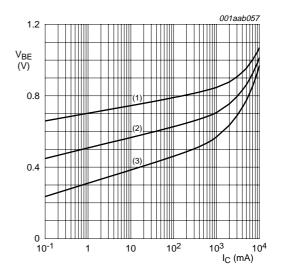
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- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

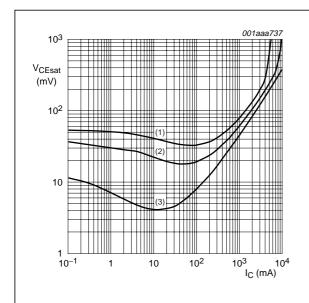
Fig.6 DC current gain as a function of collector current; typical values.



 $V_{CE} = 2 V.$ 

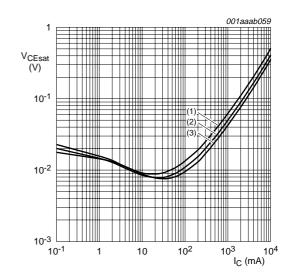
- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 100 \, ^{\circ}C$ .

Base-emitter voltage as a function of collector current; typical values.



- (1)  $I_C/I_B = 100$ .
- (2)  $I_C/I_B = 50$ .
- (3)  $I_C/I_B = 10$ .

Collector-emitter saturation voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.9 Collector-emitter saturation voltage as a function of collector current; typical values.

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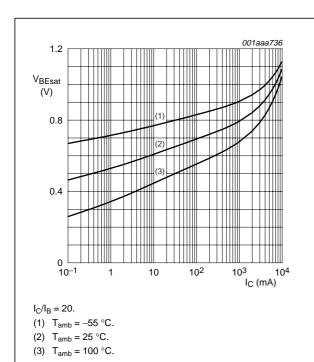


Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.

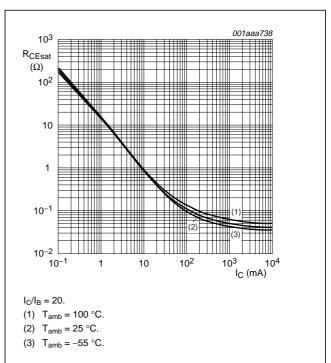
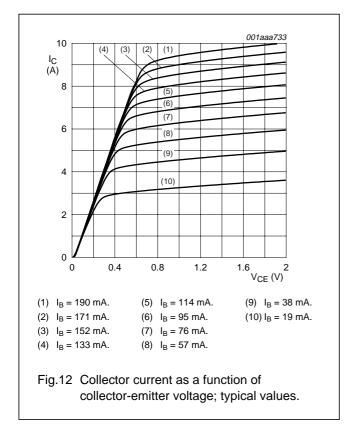
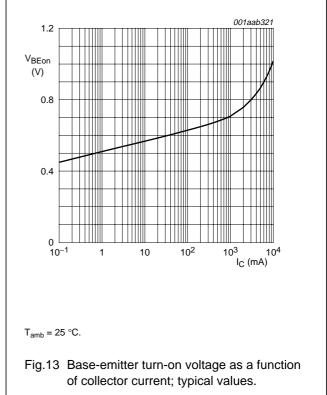


Fig.11 Equivalent on-resistance as a function of collector current; typical values.

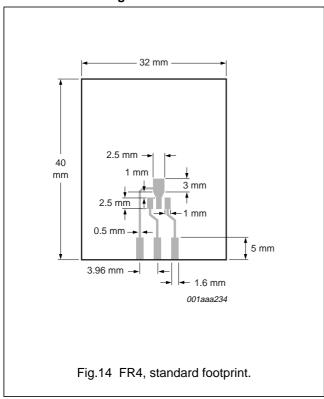


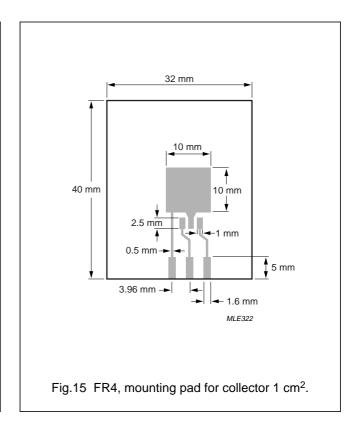


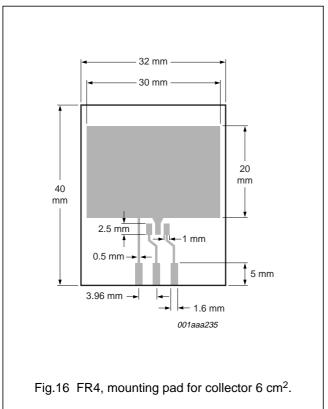
# 80 V, 4 A NPN low $V_{CEsat}$ (BISS) transistor

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## Reference mounting conditions







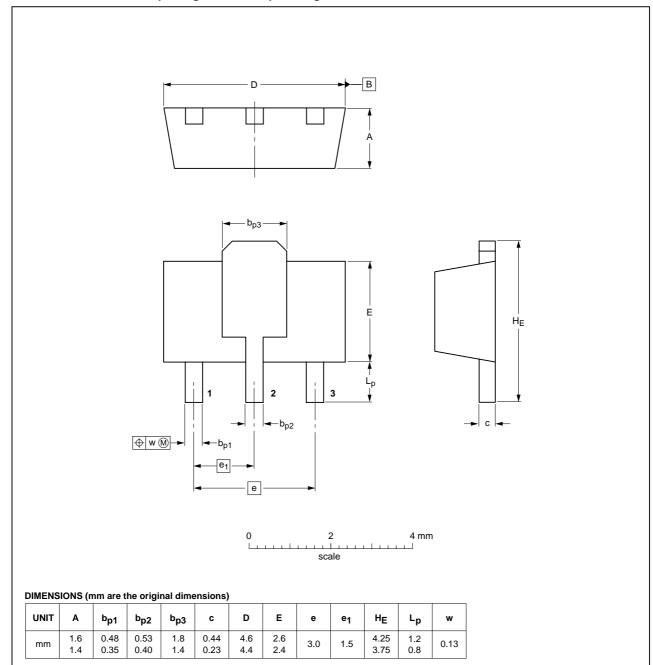
80 V, 4 A NPN low V<sub>CEsat</sub> (BISS) transistor

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## **PACKAGE OUTLINE**

## Plastic surface mounted package; collector pad for good heat transfer; 3 leads

SOT89



OUTLINE	OUTLINE REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION 1550E DAT	
SOT89		TO-243	SC-62			<del>99-09-13</del> 04-08-03

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LEVEL	DATA SHEET STATUS <sup>(1)</sup>	PRODUCT STATUS(2)(3)	DEFINITION
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- 3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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For additional information please visit http://www.semiconductors.philips.com. Fax: +31 40 27 24825 For sales offices addresses send e-mail to: sales.addresses@www.semiconductors.philips.com.

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